SN65LBC172A, SN75LBC172A Quadruple RS-485 Differential Line Drivers

1 Features

- Designed for TIA/EIA-485, TIA/EIA-422, and ISO 8482 applications
- Signaling Rates† up to 30Mbps
- Propagation delay times <11 ns
- Low standby power consumption 1.5mA max
- Output ESD protection 12 kV
- Driver positive- and negative-current limiting
- Power-up and power-down glitch-free for live insertion applications
- Thermal shutdown protection
- Industry standard pin-out, compatible with SN75172, AM26LS31, DS96172, LTC486, and MAX3045

2 Applications

- Motor drives
- Factory automation and control

3 Description

The SN65LBC172A and SN75LBC172A are quadruple differential line drivers with 3-state outputs, designed for TIA/EIA-485 (RS-485), TIA/EIA-422 (RS-422), and ISO 8482 applications.

These devices are optimized for balanced multipoint bus transmission at signaling rates up to 30 million bits per second. The transmission media may be printed-circuit board traces, backplanes, or cables. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

Each driver features current limiting and thermal-shutdown circuitry making it suitable for high-speed mulitpoint data transmission applications in noisy environments. These devices are designed using LinBiCMOS, facilitating low power consumption and robustness.

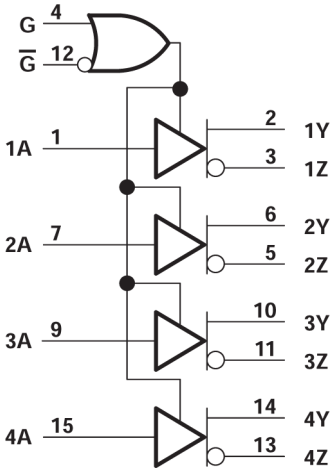
The G and $\overline{G}$ inputs provide driver enable control using either positive or negative logic. When disabled or powered off, the driver outputs present a high-impedance to the bus for reduced system loading.

The SN75LBC172A is characterized for operation over the temperature range of 0°C to 70°C. The SN65LBC172A is characterized over the temperature range from –40°C to 85°C.

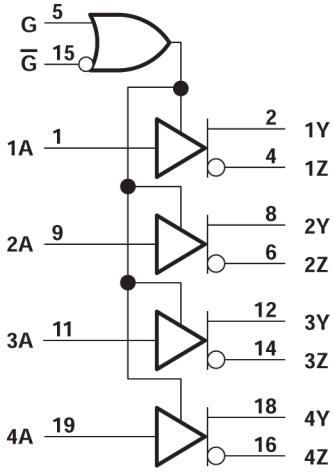
Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
SN65LBC172A SN75LBC172A	SOIC (DW, 16)	10.3mm × 10.3mm
	SOIC (DW, 20)	12.8mm × 10.3mm
	PDIP (N, 16)	19.3mm × 9.4mm

(1) For more information, see Section 11.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Logic Diagram (Positive Logic)



Logic Diagram (Positive Logic)

† The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Pin Configuration and Functions

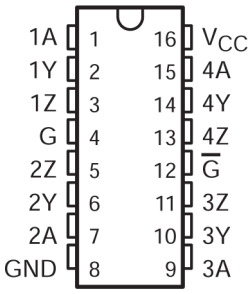

Figure 4-1. N Package (Top View)

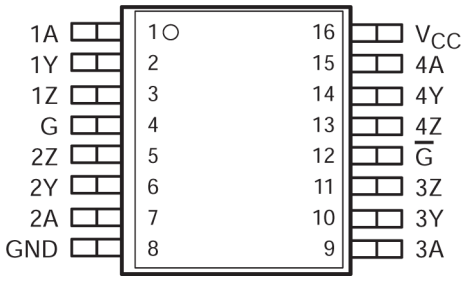

Figure 4-2. 16-DW Package (Top View)

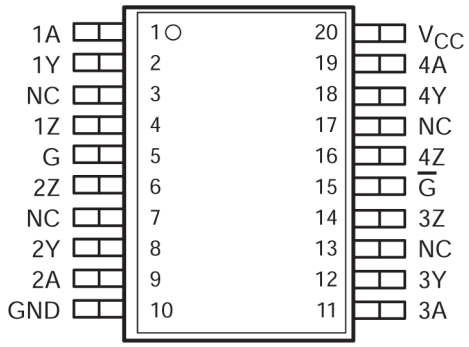

Figure 4-3. 20-DW Package (Top View)

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5 Specifications

5.1 Absolute Maximum Ratings

See Note (1)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		−0.3	6	V
V_O	Output voltage range	at any bus (steady state)	−10	15	V
V_O	Output voltage range	at any bus (transient pulse through 100Ω, see Figure 6-8)	−30	30	V
V_I	Input voltage range	at any A, G, or $\overline{G}$ terminal	−0.5	V_{CC} + 0.5	V
T_{stg}	Storage temperature range		−65	150	°C
P_D	Continuous power dissipation		See Dissipation Rating Table		
T_{LEAD}	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds			260	°C

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human body model (HBM), per AEC Q100-002(1)	Y, Z, and GND	±12000	V
		All pins	±5000	
	Charged device model (CDM), per AEC Q100-011(2)	All pins	±1000	

(1) Tested in accordance with JEDEC standard 22, Test Method A114−A.
(2) Tested in accordance with JEDEC standard 22, Test Method C101.

5.3 Dissipation Rating Table

PACKAGE	JEDEC BOARD MODEL	$T_A \le 25°C$ POWER RATING	DERATING FACTOR(1) ABOVE $T_A = 25°C$	$T_A = 70°C$ POWER RATING	$T_A = 85°C$ POWER RATING
16-PIN DW	Low K	1200mW	9.6mW/°C	769mW	625mW
	High K	2240mW	17.9mW/°C	1434mW	1165mW
20-PIN DW	Low K	1483mW	11.86mW/°C	949mW	771mW
	High K	2753mW	22mW/°C	1762mW	1432mW
16-PIN N	Low K	1150mW	9.2mW/°C	736mW	598mW

(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted with no air flow.

5.4 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}		4.75	5	5.25	V
Voltage at any bus terminal	Y, Z	−7		12	V
High-level input voltage, V_{IH}	A, G, $\overline{G}$	2		V_{CC}	V
Low-level input voltage, V_{IL}		0		0.8	
Output current		−60		60	mA
Operating free-air temperature, T_A	SN75LBC172A	0		70	°C
	SN65LBC172A	−40		85	

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5.5 Thermal Information

THERMAL METRIC[1]		N (PDIP)	DW (SOIC)	DW (SOIC)	UNIT
		16 PINS	16 PINS	20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	60.6	71.1	66.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	48.1	37.4	34.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	40.6	36.8	39.7	°C/W
ψ_{JT}	Junction-to-top characterization parameter	27.5	13.3	8.9	°C/W
ψ_{JB}	Junction-to-board characterization parameter	40.3	36.4	39	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

5.6 Electrical Characteristics

over recommended operating conditions

PARAMETER		TEST CONDITIONS		MIN	TYP[1]	MAX	UNIT
V_{IK}	Input clamp voltage	I_I = −18mA		−1.5	−0.77		V
V_O	Open-circuit output voltage	Y or Z, No load		0		V_{CC}	V
$\lvert V_{OD(SS)}\rvert$	Steady-state differential output voltage magnitude[2]	No load (open circuit)		3		V_{CC}	V
		R_L = 54Ω, see Figure 6-1		1	1.6	2.5	
		With common-mode loading, see Figure 6-2		1	1.6	2.5	
$\Delta V_{OD(SS)}$	Change in steady-state differential output voltage between logic states	See Figure 6-1		−0.1		0.1	V
$V_{OC(SS)}$	Steady-state common-mode output voltage	See Figure 6-3		2	2.4	2.8	V
$\Delta V_{OC(SS)}$	Change in steady-state common-mode output voltage between logic states	See Figure 6-3		−0.02		0.02	V
I_I	Input current	A, G, $\overline{G}$		−50		50	µA
I_{OS}	Short-circuit output current	V_{TEST} = −7V to 12V, See Figure 6-7	V_I = 0V	−200		200	mA
			V_I = V_{CC}				
I_{OZ}	High-impedance-state output current		G at 0V, $\overline{G}$ at V_{CC}	−50		50	µA
$I_{O(OFF)}$	Output current with power off		V_{CC} = 0V	−10		10	
I_{CC}	Supply current	V_I = 0V or V_{CC}, No load	All drivers enabled			23	mA
			All drivers disabled			1.5	

(1) All typical values are at V_{CC} = 5V and 25°C.
(2) The minimum V_{OD} may not fully comply with TIA/EIA-485-A at operating temperatures below 0°C. System designers should take the possibly of lower output signal into account in determining the maximum signal transmission distance.

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5.7 Switching Characteristics

over recommended operating conditions

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high level output	R_L = 54Ω, C_L = 50pF, see Figure 6-4	5.5	8	11	ns
t_{PHL}	Propagation delay time, high-to-low level output		5.5	8	11	ns
t_r	Differential output voltage rise time		2	7.5	11	ns
t_f	Differential output voltage fall time		2	7.5	11	ns
$t_{sk(p)}$	Pulse skew $\|t_{PLH} - t_{PHL}\|$			0.6	2	ns
$t_{sk(o)}$	Output skew(1)				2	ns
$t_{sk(pp)}$	Part-to-part skew(2)				3	ns
t_{PZH}	Propagation delay time, high-impedance-to-high-level output	See Figure 6-5			25	ns
t_{PHZ}	Propagation delay time, high-level-output-to-high impedance				25	ns
t_{PZL}	Propagation delay time, high-impedance-to-low-level output	See Figure 6-6			30	ns
t_{PLZ}	Propagation delay time, low-level-output-to-high impedance				20	ns

(1) Output skew ($t_{sk(o)}$) is the magnitude of the time delay difference between the outputs of a single device with all of the inputs connected together.

(2) Part-to-part skew ($t_{sk(pp)}$) is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same input signals, the same supply voltages, at the same temperature, and have identical packages and test circuits.

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5.8 Typical Characteristics

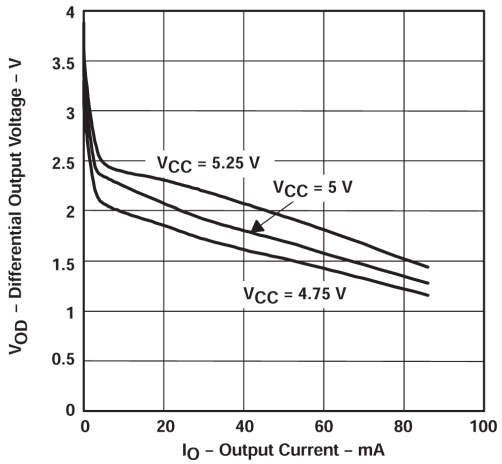

Figure 5-1. Differential Output Voltage vs Output Current

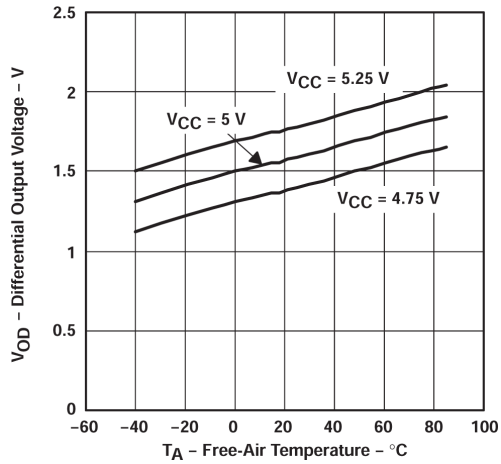

Figure 5-2. Differential Output Voltage vs Free-air Temperature

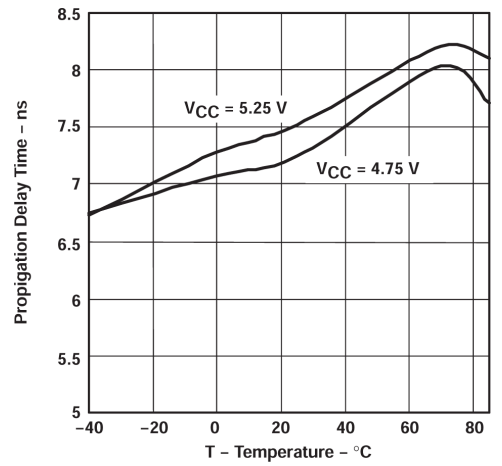

Figure 5-3. Propagation Delay Time vs Temperature

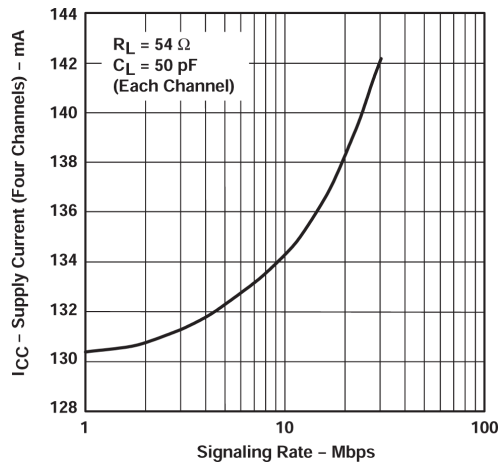

Figure 5-4. Supply Current (Four Channels) vs Signaling Rate

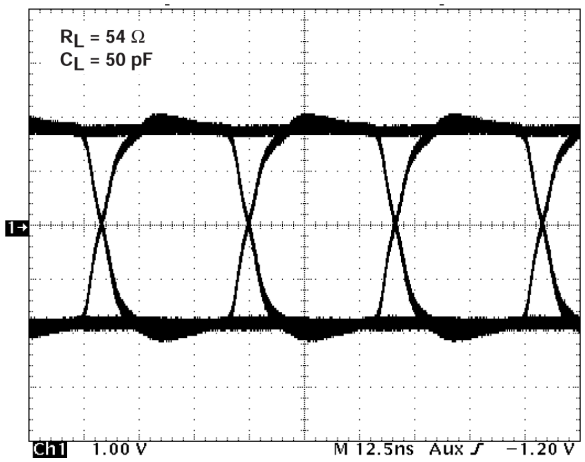

Figure 5-5. Eye Pattern, Pseudorandom Data at 30Mbps

6 Parameter Measurement Information

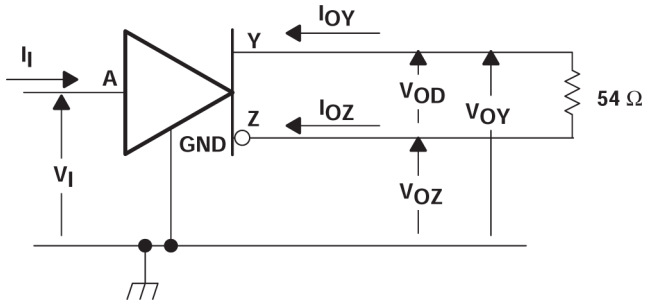

Figure 6-1. Test Circuit, V_{OD} Without Common-Mode Loading

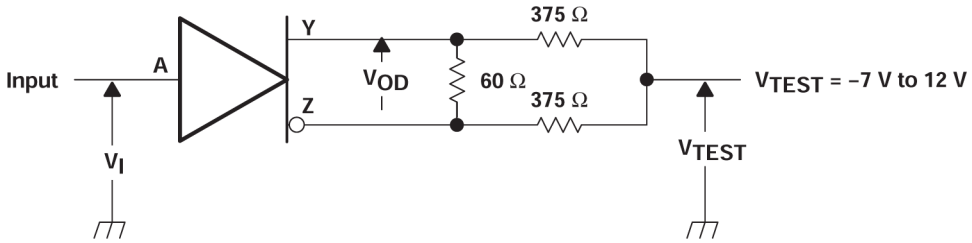

Figure 6-2. Test Circuit, V_{OD} With Common-Mode Loading

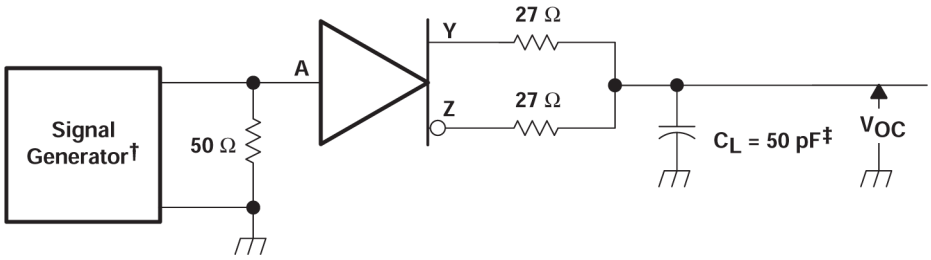

Figure 6-3. V_{OC} Test Circuit

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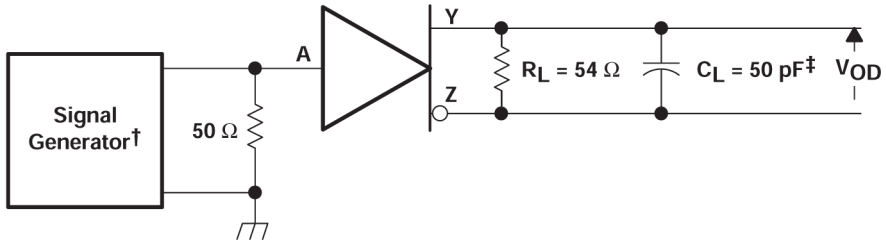


† PRR = 1 MHz, 50% duty cycle, t_r < 6 ns, t_f < 6 ns, Z_O = 50 Ω

‡ Includes probe and jig capacitance

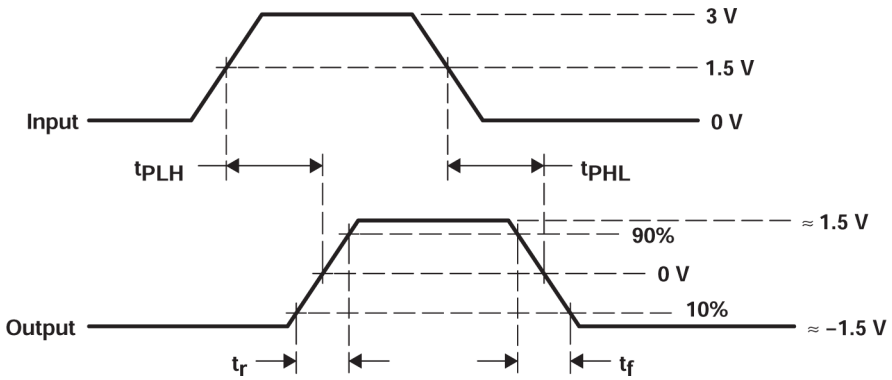
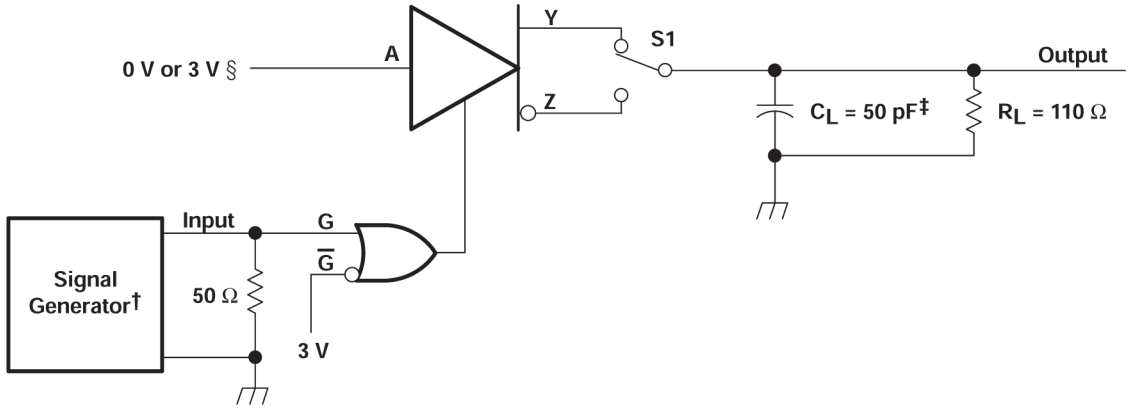


Figure 6-4. Output Switching Test Circuit and Waveforms



† PRR = 1 MHz, 50% duty cycle, t_r < 6 ns, t_f < 6 ns, Z_O = 50 Ω
‡ Includes probe and jig capacitance
§ 3-V if testing Y output, 0 V if testing Z output

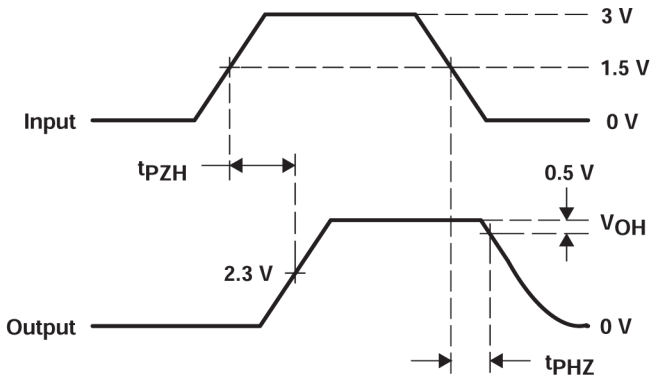


Figure 6-5. Enable Timing Test Circuit and Waveforms, t_{PZH} and t_{PHZ}

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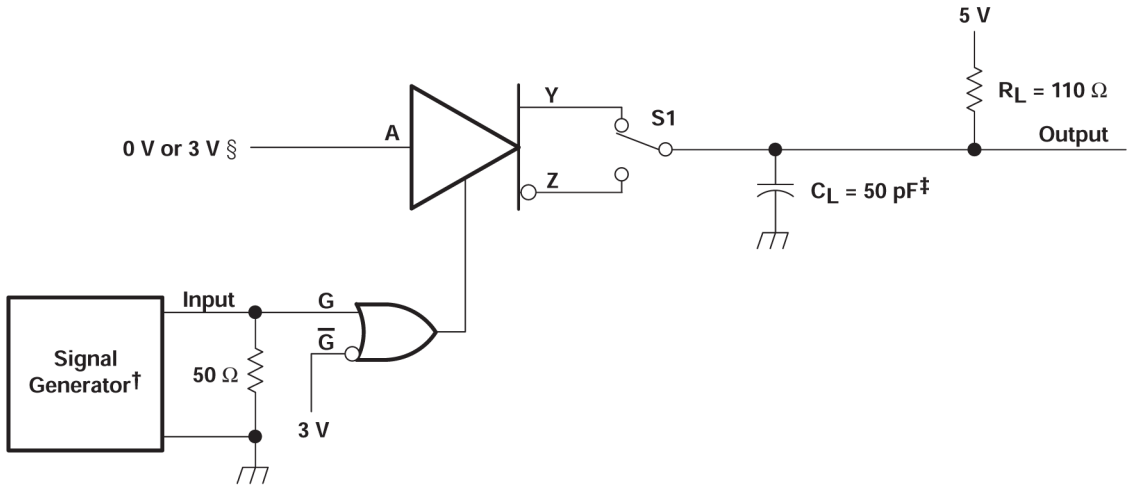

† PRR = 1 MHz, 50% duty cycle, t_r < 6 ns, t_f < 6 ns, Z_O = 50 Ω
‡ Includes probe and jig capacitance
§ 3-V if testing Y output, 0 V if testing Z output

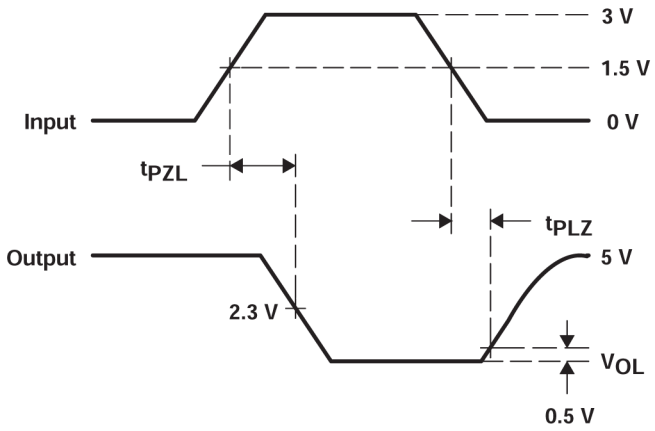

Figure 6-6. Enable Timing Test Circuit and Waveforms, t_{PZL} and t_{PLZ}

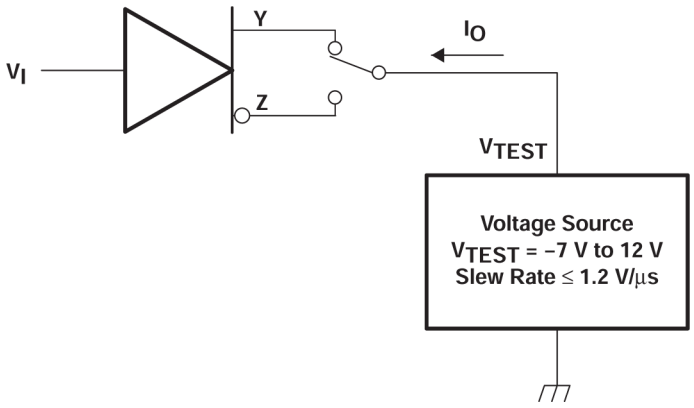

Figure 6-7. Test Circuit, Short-Circuit Output Current

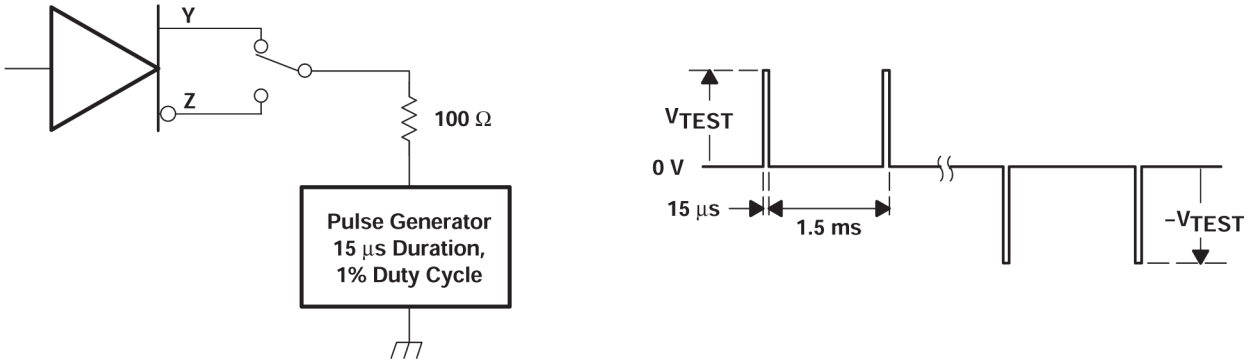

Figure 6-8. Test Circuit and Waveform, Transient Over-Voltage

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7 Detailed Description

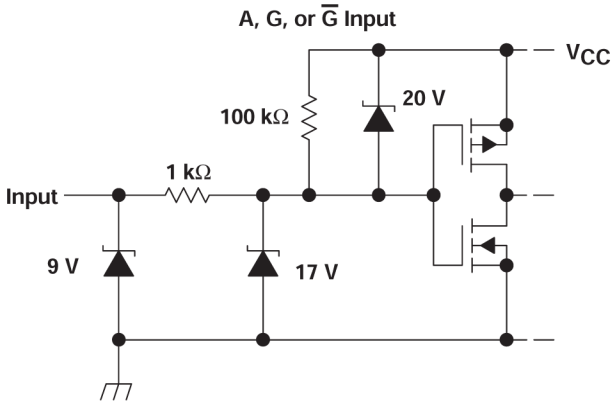
7.1 Device Functional Modes

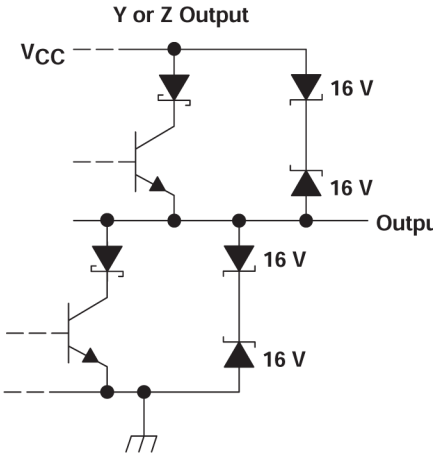
7.1.1 Function Table

Table 7-1. (Each Driver)

INPUT	ENABLES		OUTPUTS	
A	G	$\overline{G}$	Y	Z
L	H	X	L	H
L	X	L	L	H
H	H	X	H	L
H	X	L	H	L
OPEN	H	X	H	L
OPEN	X	L	H	L
H	OPEN	X	H	L
L	OPEN	X	L	H
X	L	H	Z	Z
X	L	OPEN	Z	Z

7.1.2 Equivalent Input and Output Schematic Diagrams





8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

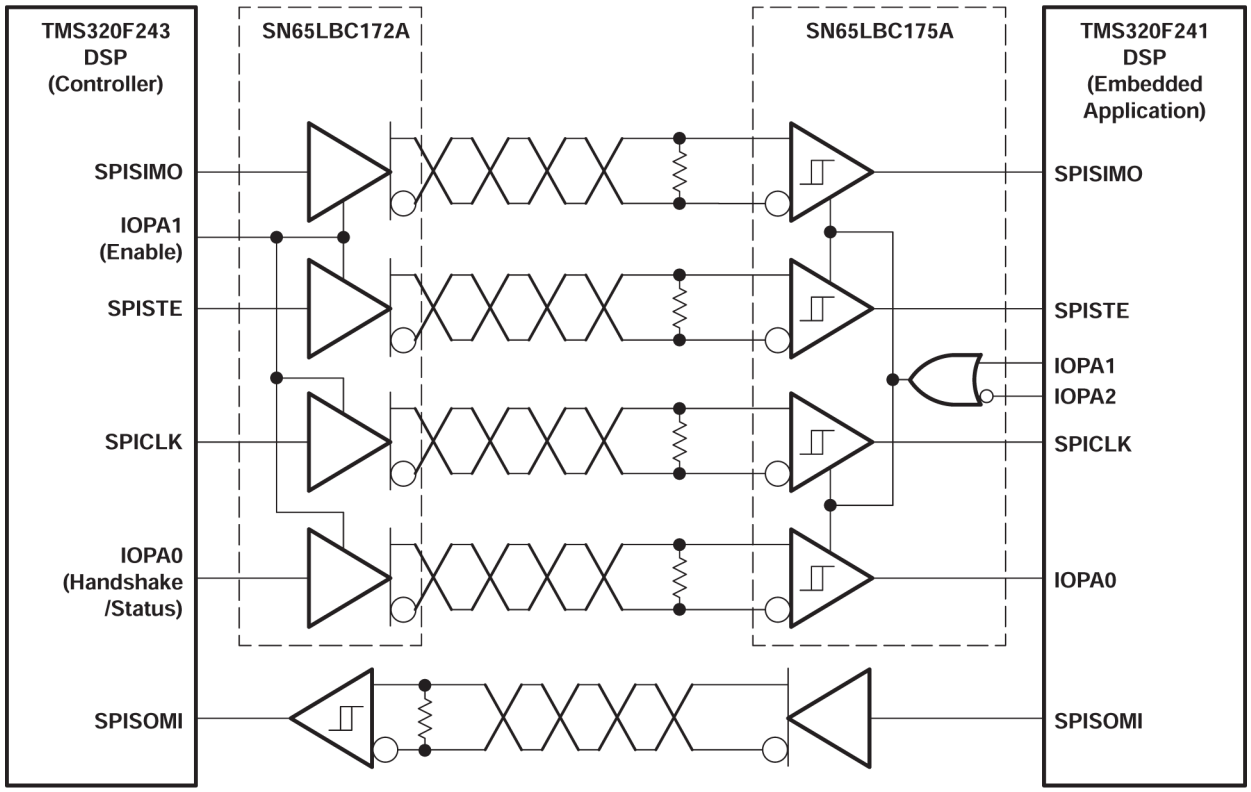


Figure 8-1. Typical Application Circuit, DSP-to-DSP Link via Serial Peripheral Interface

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9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Documentation Support

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (August 2008) to Revision D (April 2024)	Page
• Changed the numbering format for tables, figures, and cross-references throughout the document	1
• Added the *Thermal Information* table	5

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN65LBC172A16DW	Obsolete	Production	SOIC (DW) | 16	-	-	Call TI	Call TI	-40 to 85	65LBC172A
SN65LBC172A16DWR	Active	Production	SOIC (DW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC172A
SN65LBC172A16DWR.A	Active	Production	SOIC (DW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC172A
SN65LBC172ADW	Obsolete	Production	SOIC (DW) | 20	-	-	Call TI	Call TI	-40 to 85	65LBC172A
SN65LBC172ADWR	Active	Production	SOIC (DW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC172A
SN65LBC172ADWR.A	Active	Production	SOIC (DW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC172A
SN65LBC172AN	Active	Production	PDIP (N) | 16	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	65LBC172A
SN65LBC172AN.A	Active	Production	PDIP (N) | 16	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	65LBC172A
SN65LBC172ANE4	Active	Production	PDIP (N) | 16	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	65LBC172A
SN75LBC172A16DW	Obsolete	Production	SOIC (DW) | 16	-	-	Call TI	Call TI	0 to 70	75LBC172A
SN75LBC172A16DWR	Obsolete	Production	SOIC (DW) | 16	-	-	Call TI	Call TI	0 to 70	75LBC172A
SN75LBC172ADW	Obsolete	Production	SOIC (DW) | 20	-	-	Call TI	Call TI	0 to 70	75LBC172A
SN75LBC172ADWR	Obsolete	Production	SOIC (DW) | 20	-	-	Call TI	Call TI	0 to 70	75LBC172A
SN75LBC172AN	Obsolete	Production	PDIP (N) | 16	-	-	Call TI	Call TI	0 to 70	75LBC172A

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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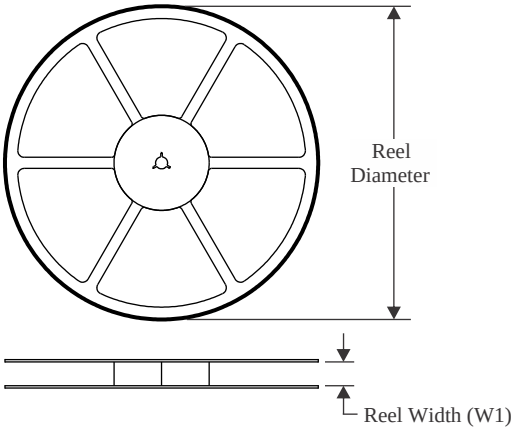
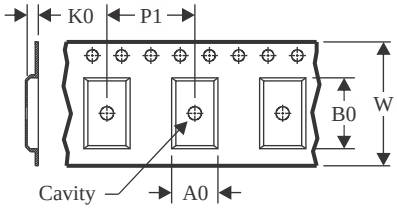
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

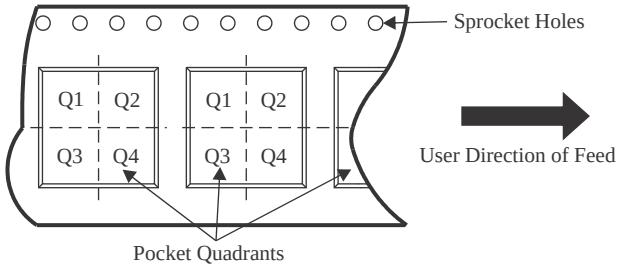


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

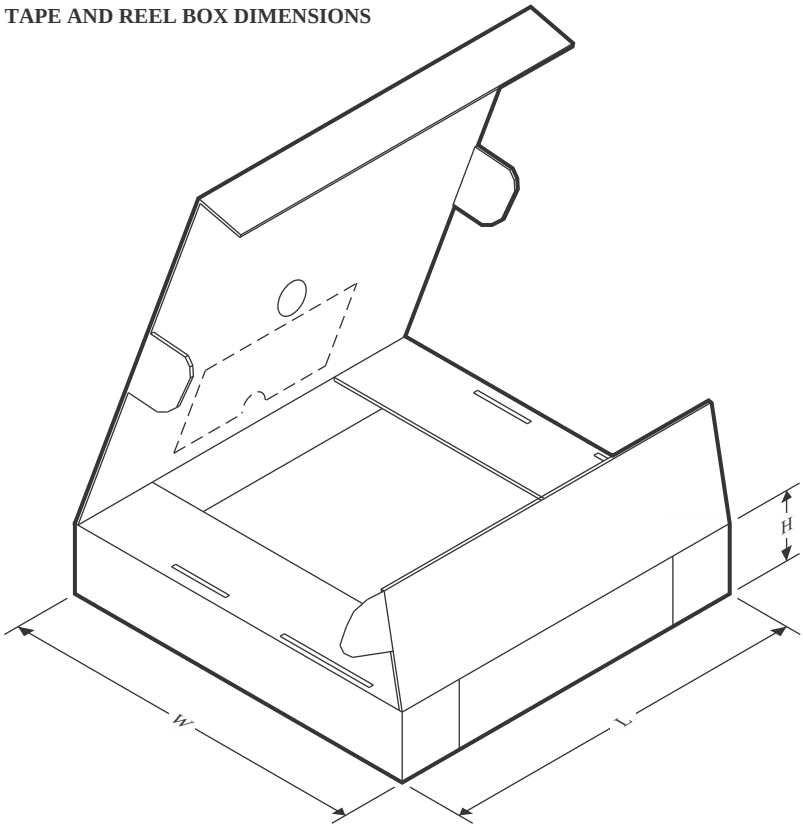
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LBC172A16DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
SN65LBC172ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN65LBC172ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1

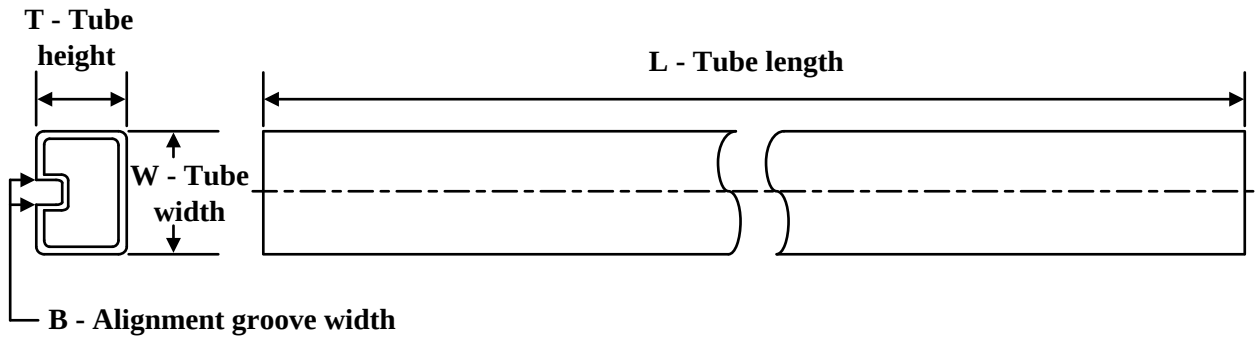
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LBC172A16DWR	SOIC	DW	16	2000	350.0	350.0	43.0
SN65LBC172ADWR	SOIC	DW	20	2000	356.0	356.0	45.0
SN65LBC172ADWR	SOIC	DW	20	2000	367.0	367.0	45.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN65LBC172AN	N	PDIP	16	25	506	13.97	11230	4.32
SN65LBC172AN.A	N	PDIP	16	25	506	13.97	11230	4.32
SN65LBC172ANE4	N	PDIP	16	25	506	13.97	11230	4.32

GENERIC PACKAGE VIEW

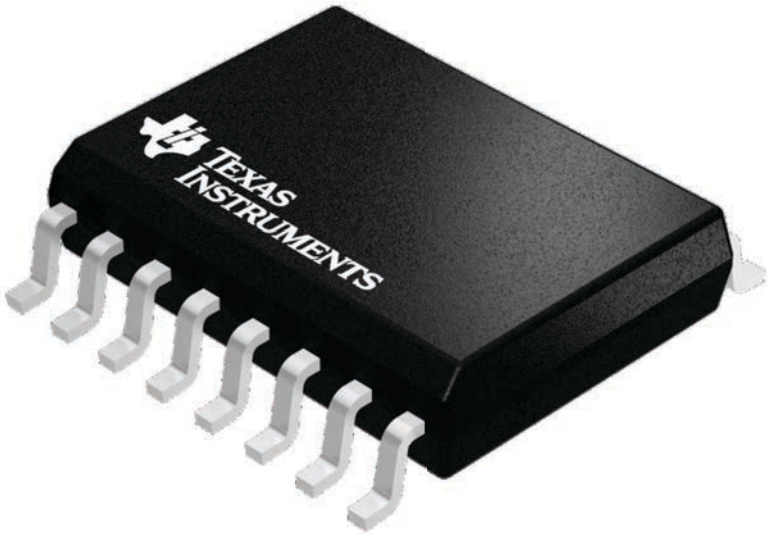
DW 16

SOIC - 2.65 mm max height

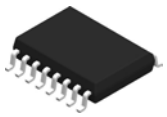
7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224780/A

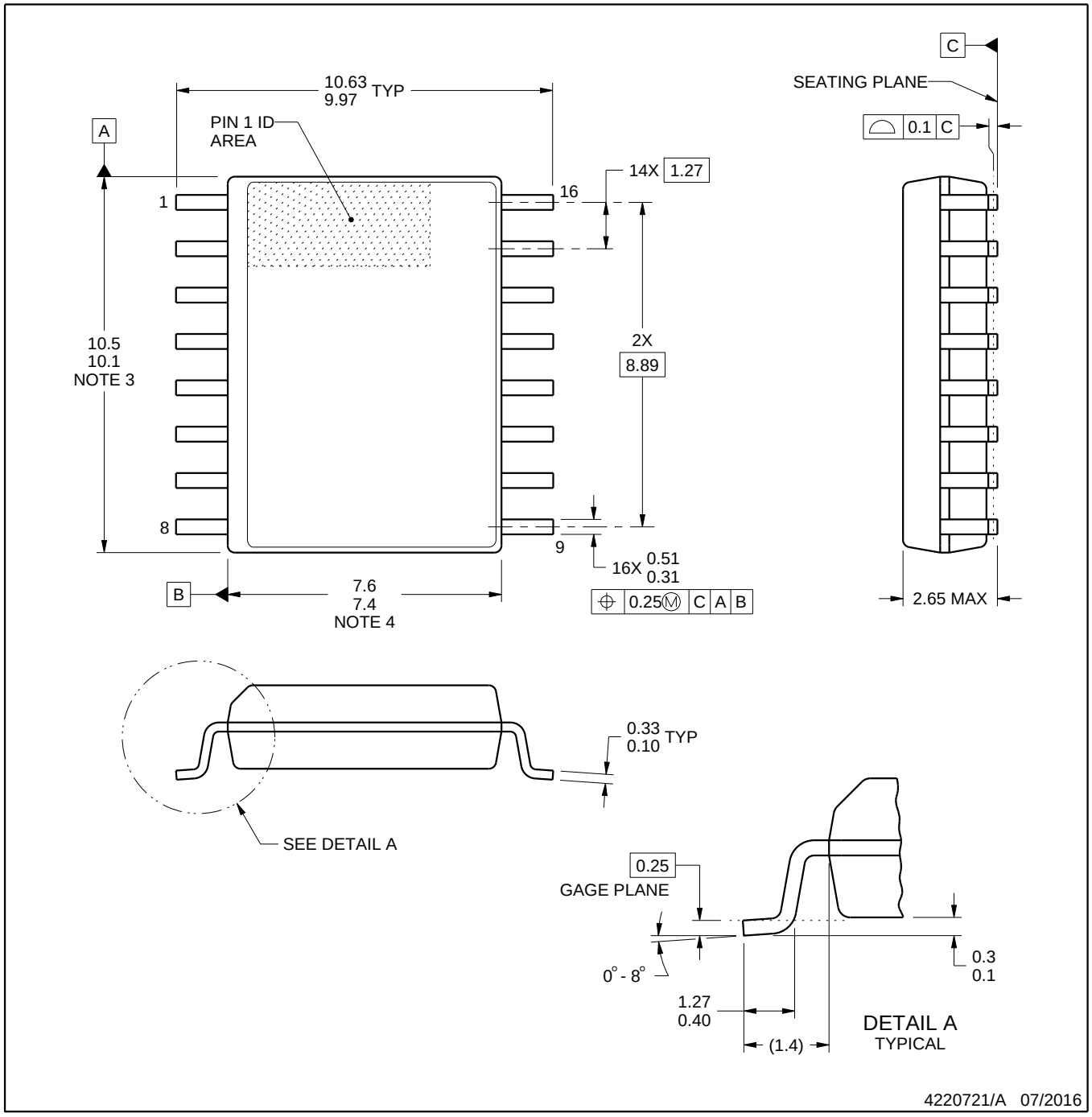


PACKAGE OUTLINE

DW0016A

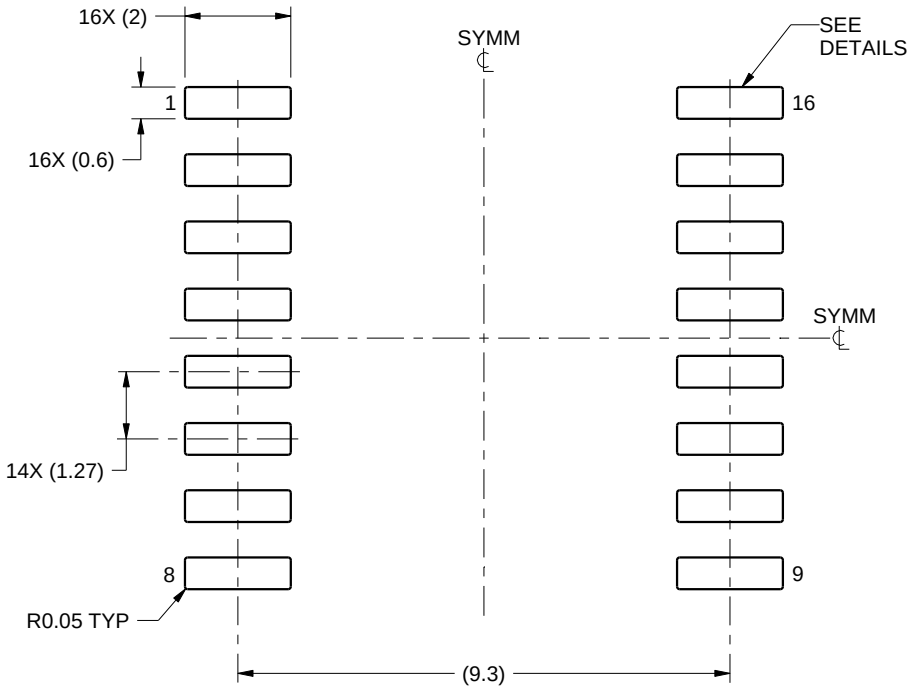
SOIC - 2.65 mm max height

SOIC

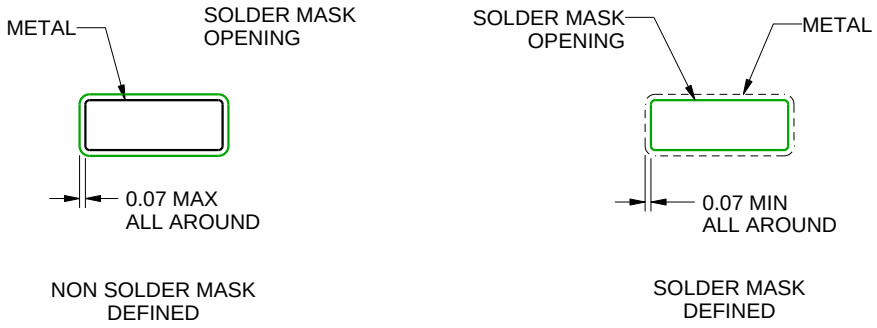


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.



LAND PATTERN EXAMPLE
SCALE:7X

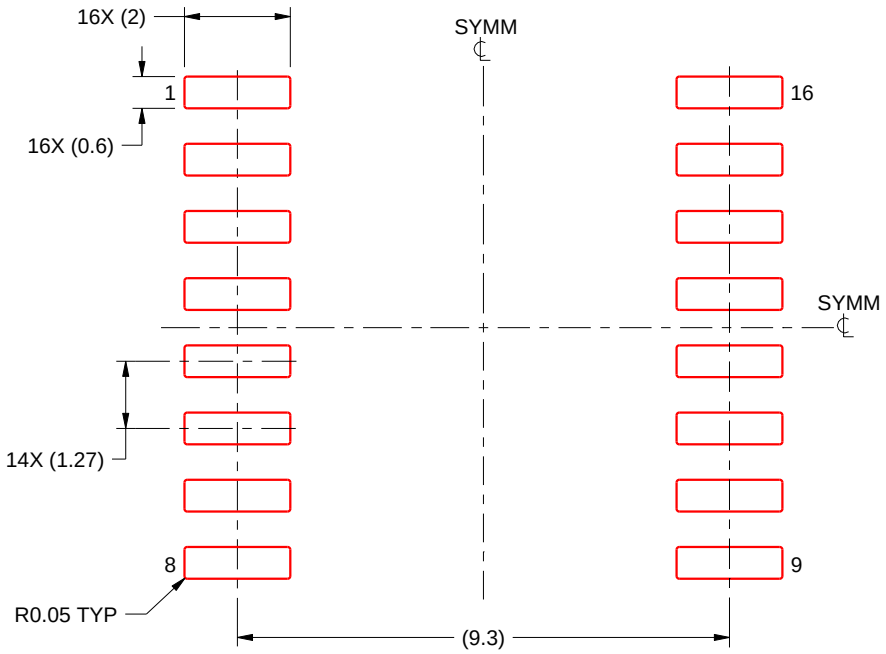


SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

4220721/A 07/2016

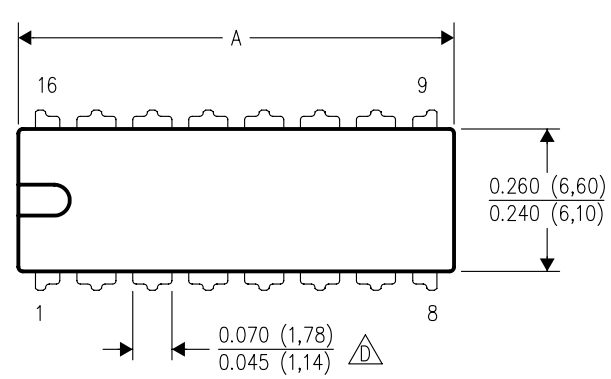
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

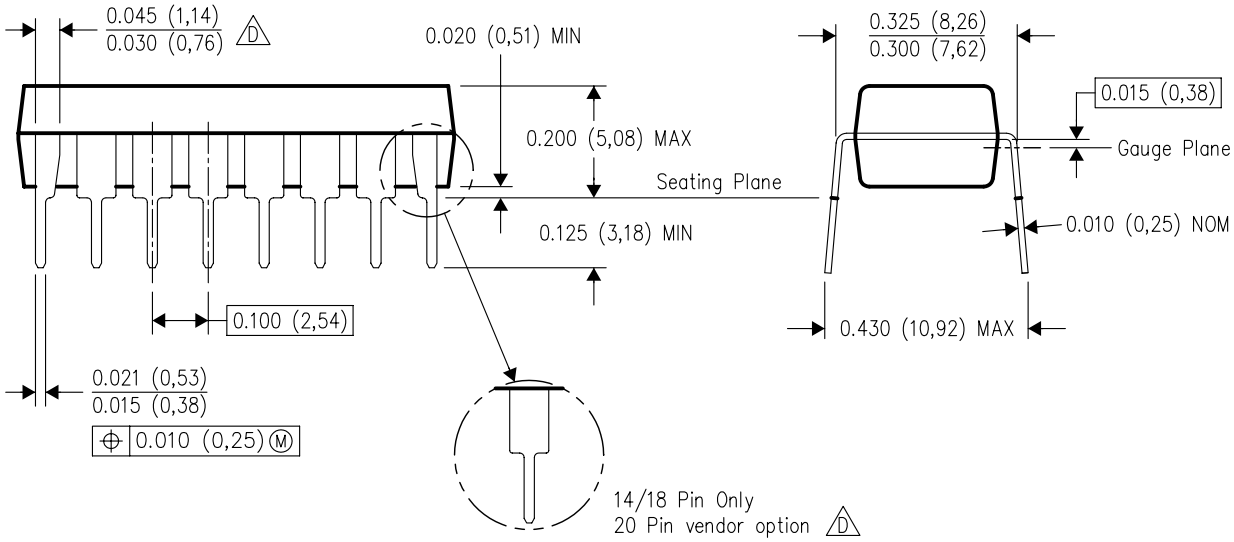
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN

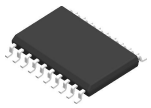


DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



4040049/E 12/2002

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

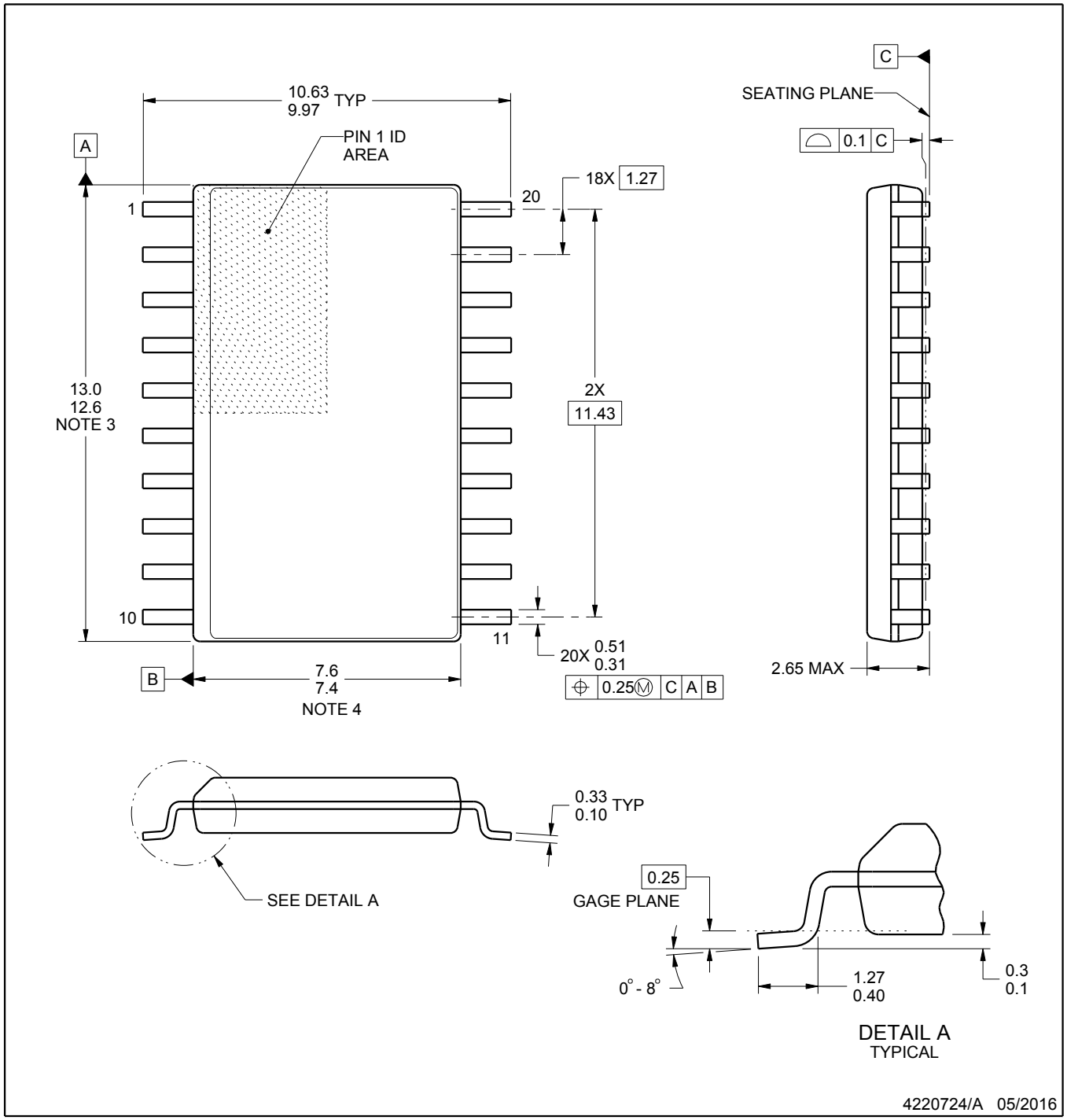


PACKAGE OUTLINE

DW0020A

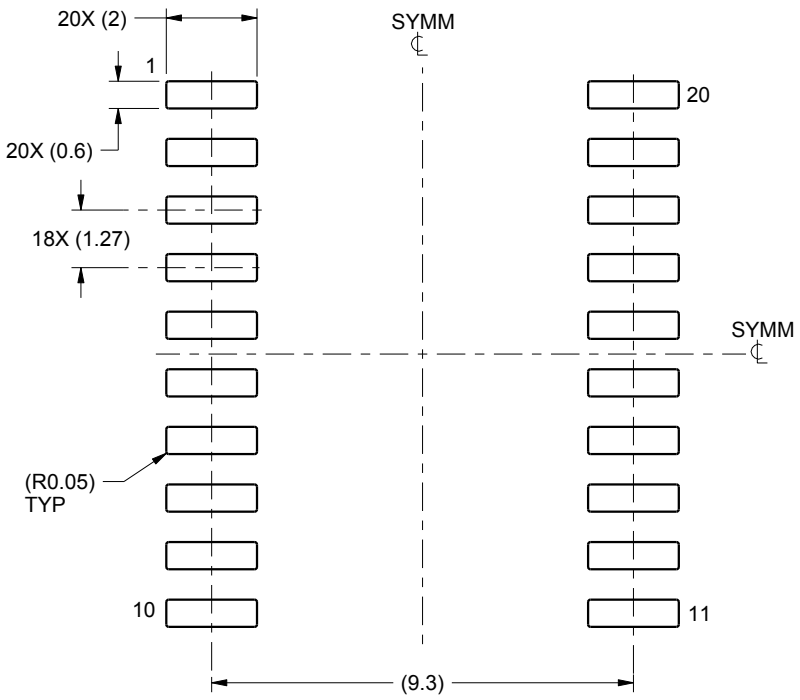
SOIC - 2.65 mm max height

SOIC

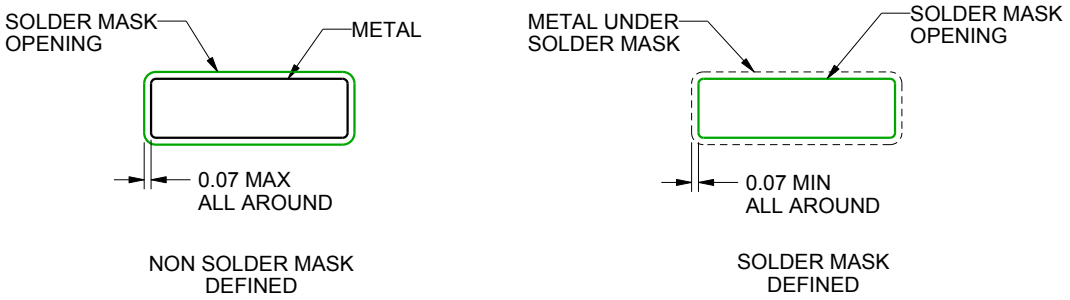


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.



LAND PATTERN EXAMPLE
SCALE:6X

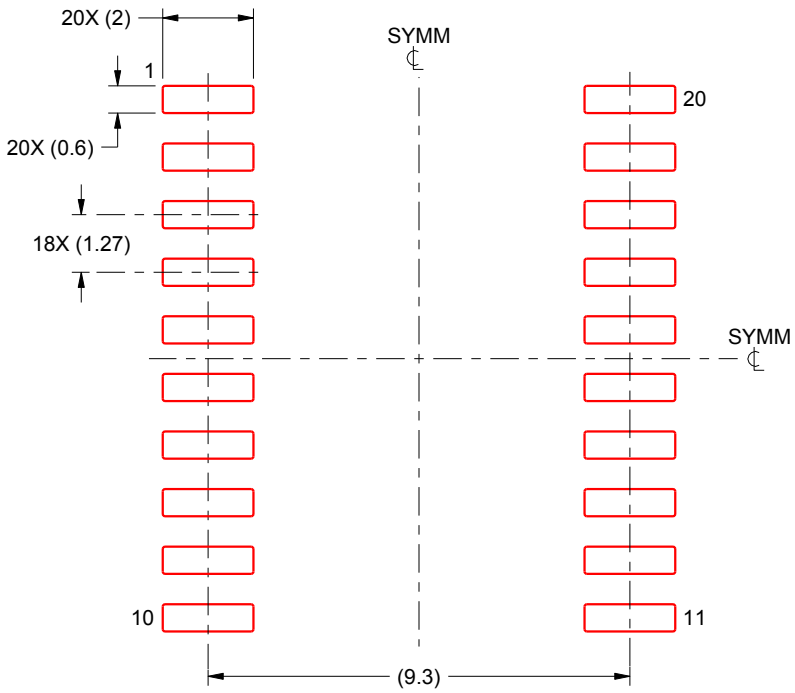


SOLDER MASK DETAILS

4220724/A 05/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

4220724/A 05/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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